

1A, Single-Input, Single-Cell LiFePO₄ Linear Battery Charger with 50mA LDO

 Check for Samples: [bq25070](#)

FEATURES

- Single Cell LiFePO₄ Charging Algorithm
- 30V Input Rating, With 10.5V Over-Voltage Protection (OVP)
- 50mA Integrated Low Dropout Linear Regulator (LDO)
- Programmable Charge Current Through Single Input Interface (CTRL)
- 7% Charge Current Regulation Accuracy
- Thermal Regulation and Protection
- Soft-Start Feature to Reduce Inrush Current

- Battery NTC Monitoring
- Charging Status Indication
- Available in Small 2mm × 3mm 10 Pin SON Package

APPLICATIONS

- Smart Phones
- Mobile Phones
- Portable Media Players
- Low Power Handheld Devices

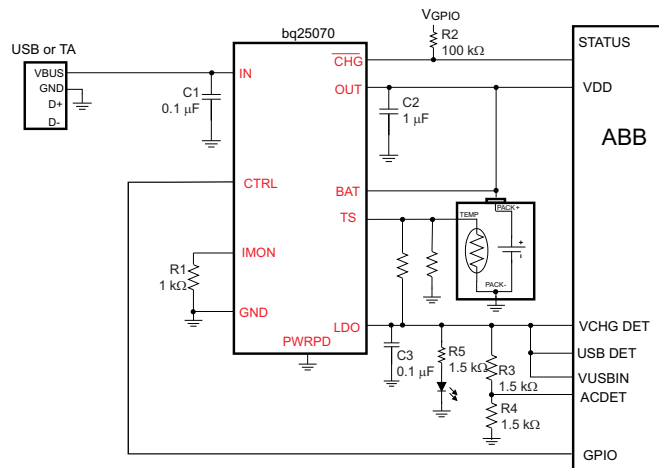
DESCRIPTION

The bq25070 is a highly integrated LiFePO₄ linear battery charger targeted at space-limited portable applications. It operates from either a USB port or AC Adapter and charges a single-cell LiFePO₄ battery with up to 1A of charge current. The 30V input voltage range with input over-voltage protections supports low-cost unregulated adapters.

The bq25070 has a single power output that charges the battery and powers the system. The charge current is programmable up to 1A using the CTRL input. Additionally, a 4.9V ±10% 50mA LDO is integrated into the IC for supplying low power external circuitry.

The LiFePO₄ charging algorithm removes the constant voltage mode control usually present in Li-Ion battery charge cycles. Instead, the battery is fastcharged to the overcharge voltage and then allowed to relax to a lower float charge voltage threshold. The removal of the constant voltage control reduces charge time significantly. During the charge cycle, an internal control loop monitors the IC junction temperature and reduces the charge current if an internal temperature threshold is exceeded. The charger power stage and charge current sense functions are fully integrated. The charger function has high accuracy current and voltage regulation loops, and charge status display.

APPLICATION SCHEMATIC



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

ORDERING INFORMATION⁽¹⁾

PART NUMBER	I _{LIM(DEF)}	V _{BAT(OVCH)}	V _{BAT(FLOAT)}	V _{OVP}	V _{LDO}	MARKING
bq25070DQCR	300 mA	3.7 V	3.5 V	10.5 V	4.9 V	QUS
bq25070DQCT	300 mA	3.7 V	3.5 V	10.5 V	4.9 V	QUS

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or visit the device product folder on ti.com (www.ti.com),

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

		VALUE	UNIT
Input Voltage	IN (with respect to GND)	-0.3 to 30	V
	CTRL, TS (with respect to GND)	-0.3 to 7	V
Output Voltage	BAT, OUT, LDO, $\overline{\text{CHG}}$, IMON (with respect to GND)	-0.3 to 7	V
Input Current (Continuous)	IN	1.2	A
Output Current (Continuous)	BAT	1.2	A
Output Current (Continuous)	LDO	100	mA
Output Sink Current	$\overline{\text{CHG}}$	5	mA
Junction temperature, T _J		-40 to 150	°C
Storage temperature, T _{STG}		-65 to 150	°C

(1) Stresses beyond those listed under *absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *recommended operating conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. All voltage values are with respect to the network ground terminal unless otherwise noted.

THERMAL INFORMATION

THERMAL METRIC ⁽¹⁾		bq25070	UNITS
		SON	
		10 PINS	
θ_{JA}	Junction-to-ambient thermal resistance ⁽²⁾	58.7	°C/W
θ_{JCTop}	Junction-to-case (top) thermal resistance ⁽³⁾	3.9	

- (1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, [SPRA953](#).
 (2) The junction-to-ambient thermal resistance under natural convection is obtained in a simulation on a JEDEC-standard, high-K board, as specified in JESD51-7, in an environment described in JESD51-2a.
 (3) The junction-to-case (top) thermal resistance is obtained by simulating a cold plate test on the package top. No specific JEDEC-standard test exists, but a close description can be found in the ANSI SEMI standard G30-88.

RECOMMENDED OPERATING CONDITIONS

		MIN	MAX	UNITS
V _{IN}	IN voltage range	3.75 ⁽¹⁾	28	V
	IN operating voltage range	3.75 ⁽¹⁾	10.2	
I _{IN}	Input current, IN		1	A
I _{OUT}	Output Current in charge mode, OUT		1	A
T _J	Junction Temperature	0	125	°C

(1) Charge current may be limited at low input voltages due to the dropout of the device.

ELECTRICAL CHARACTERISTICS

Over junction temperature range $0^{\circ}\text{C} \leq T_J \leq 125^{\circ}\text{C}$ and recommended supply voltage (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNITS
INPUT						
V_{UVLO}	Under-voltage lock-out	$V_{IN}: 0\text{ V} \rightarrow 4\text{ V}$	3.15	3.30	3.55	V
$V_{HYS-UVLO}$	Hysteresis on UVLO	$V_{IN}: 4\text{ V} \rightarrow 0\text{ V}$		250		mV
$V_{BATUVLO}$	Battery UVLO	V_{BAT} rising	1.95	2.05	2.15	V
$V_{HYS-BUVLO}$	Hysteresis on BAT UVLO	V_{BAT} falling		125		mV
V_{IN-SLP}	Valid input source threshold V_{IN-SLP} above V_{BAT}	Input power good if $V_{IN} > V_{BAT} + V_{IN-SLP}$ $V_{BAT} = 3.6\text{ V}$, $V_{IN}: 3.5\text{ V} \rightarrow 4\text{ V}$	30	75	150	mV
$V_{HYS-INSLP}$	Hysteresis on V_{IN-SLP}	$V_{BAT} = 3.6\text{ V}$, $V_{IN}: 4\text{ V} \rightarrow 3.5\text{ V}$	18	32	54	mV
$t_{DGL(NO-IN)}$	Delay time, input power loss to charger turn-off	Time measured from $V_{IN}: 5\text{ V} \rightarrow 2.5\text{ V}$ 1 μs fall-time		32		ms
V_{OVP}	Input over-voltage protection threshold	$V_{IN}: 5\text{ V} \rightarrow 11\text{ V}$	10.2	10.5	10.8	V
$V_{HYS-OVP}$	Hysteresis on OVP	$V_{IN}: 11\text{ V} \rightarrow 5\text{ V}$		100		mV
$t_{BLK(OVP)}$	Input over-voltage blanking time			100		μs
$t_{REC(OVP)}$	Input over-voltage recovery time	Time measured from $V_{IN}: 11\text{ V} \rightarrow 5\text{ V}$ 1 μs fall-time to LDO = HI, $V_{BAT} = 3.5\text{ V}$		100		μs
QUIESCENT CURRENT						
$I_{BAT(PDWN)}$	Battery current into BAT, No input connected	$V_{IN} = 0\text{ V}$, $\overline{V_{CHG}} = \text{High}$, TS Enabled		120	150	μA
		$V_{IN} = 0\text{ V}$, $\overline{V_{CHG}} = \text{Low}$, TS Disabled, $T_J = 85^{\circ}\text{C}$			6	μA
$I_{IN(STDBY)}$	Standby current into IN pin	CTRL = HI, $V_{IN} = 5.5\text{ V}$			0.25	mA
		CTRL = HI, $V_{IN} \leq V_{OVP}$			0.5	
		CTRL = HI, $V_{IN} > V_{OVP}$			2	
ICC	Active supply current, IN pin	$V_{IN} = 6\text{ V}$, No load on OUT pin, $V_{BAT} > V_{BAT(REG)}$, IC enabled			3	mA
BATTERY CHARGER FAST-CHARGE						
$V_{BAT(REG)}$	Battery float charge voltage	$T_A = 0^{\circ}\text{C}$ to 125°C	3.465	3.5	3.535	V
		$T_A = 25^{\circ}\text{C}$	3.465	3.5	3.529	
$V_{BAT(OVCH)}$	Battery overcharge voltage threshold		3.62	3.7	3.78	V
$I_{IN(LIM)}$	Input Current Limit (selected by CTRL interface)	4 pulses on CTRL	87	93	100	mA
		5 pulses on CTRL	174	187	200	
		6 pulses on CTRL	261	280	300	
		7 pulses on CTRL	348	374	400	
		8 pulses on CTRL	435	467	500	
		9 pulses on CTRL	608	654	700	
		10 pulses on CTRL	739	794	850	
		11 pulses on CTRL	869	935	1000	
$V_{DO(IN-OUT)}$	$V_{IN} - V_{OUT}$	$V_{IN} = 3.5\text{ V}$, $I_{OUT} = 0.75\text{ A}$		500	1400	mV
K_{IMON}	Input current monitor ratio	$K_{IMON} = I_{IMON} / I_{CHG}$, $R_{IMON} = 1\text{k}\Omega$, Current programmed using CTRL		1		mA / A
$V_{IMON(MAX)}$	Maximum IMON voltage	IMON open		1.2	1.25	V
	IMON Accuracy	$I_{IN} < 100\text{ mA}$	-25%		25%	
		$I_{IN} = 100\text{ mA}$ to 1 A	-10%		10%	
PRE-CHARGE AND CHARGE DONE						
V_{LOWV}	Pre-charge to fast-charge transition threshold		2.4	2.5	2.6	V
$t_{DGL1(LOWV)}$	Deglintch time on pre-charge to fast-charge transition			25		ms
$t_{DGL2(LOWV)}$	Deglintch time on fast-charge to pre-charge transition			25		ms

ELECTRICAL CHARACTERISTICS (continued)

Over junction temperature range $0^{\circ}\text{C} \leq T_J \leq 125^{\circ}\text{C}$ and recommended supply voltage (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNITS
$I_{\text{PRECHARGE}}$	Precharge current to BAT during precharge mode	$V_{\text{BAT}} = 0 \text{ V to } 0.7 \text{ V}$	41.5	45	48.5	mA
RECHARGE OR REFRESH						
V_{RCH}	Recharge detection threshold	V_{BAT} falling	3.1	3.3	3.5	V
$t_{\text{DGL(RCH)}}$	Deglintch time, recharge threshold detected	V_{BAT} falling to New Charge Cycle		25		ms
LDO						
V_{LDO}	LDO Output Voltage	$V_{\text{IN}} = 5 \text{ V to } 10.5 \text{ V}$, $I_{\text{LDO}} = 0 \text{ mA to } 50 \text{ mA}$	4.7	4.9	5.1	V
I_{LDO}	Maximum LDO Output Current		60			mA
V_{DO}	Dropout Voltage	$V_{\text{IN}} = 4.5\text{V}$, $I_{\text{LDO}} = 50\text{mA}$		200	350	mV
CTRL INTERFACE						
$t_{\text{CTRL_DGL}}$	CTRL Deglitch timer		5			ms
$t_{\text{CTRL_LATCH}}$	CTRL Latch timer		2			ms
$t_{\text{HI_MIN}}$	High Duration on CTRL		50		1000	μs
$t_{\text{LO_MIN}}$	Low Time Duration on CTRL		50		1000	μs
R_{PULLDOWN}	CTRL Pulldown Resistor			260		k Ω
LOGIC LEVELS ON CTRL						
V_{IL}	Logic LOW input voltage				0.4	V
V_{IH}	Logic HIGH input voltage		1.4			V
BATTERY-PACK NTC MONITOR (TS)						
V_{COLD}	TS Cold Threshold	V_{TS} Rising	24.5	25	25.5	$\%V_{\text{LDO}}$
V_{CUTOFF}	TS Cold Cutoff Threshold	V_{TS} Falling		1		$\%V_{\text{LDO}}$
V_{HOT}	TS Hot Threshold	V_{TS} Falling	12	12.5	13	$\%V_{\text{LDO}}$
$V_{\text{HOT_HYS}}$	TS Hot Cutoff Threshold	V_{TS} Rising		1		$\%V_{\text{LDO}}$
$t_{\text{dgl(TS)}}$	Deglitch for TS Fault	Fault detected on TS to stop charge		25		ms
CHG OUTPUT						
V_{OL}	Output LOW voltage	$I_{\text{SINK}} = 1 \text{ mA}$			0.45	V
I_{IH}	Leakage current	$\overline{\text{CHG}} = 5 \text{ V}$			1	μA
$t_{\text{FLSH(TS)}}$	TS fault flash period	50% Duty Cycle, TS out of valid range		100		ms
THERMAL REGULATION						
$T_{\text{J(REG)}}$	Temperature Regulation Limit	T_J rising		125		C
$T_{\text{J(OFF)}}$	Thermal shutdown temperature	T_J rising		155		C
$T_{\text{J(OFF-HYS)}}$	Thermal shutdown hysteresis	T_J falling		20		C

TYPICAL CHARACTERISTICS

$V_{IN} = 5\text{ V}$, $V_{BAT} = 3.2\text{ V}$, $I_{CHG} = 280\text{ mA}$, Typical Application Circuit

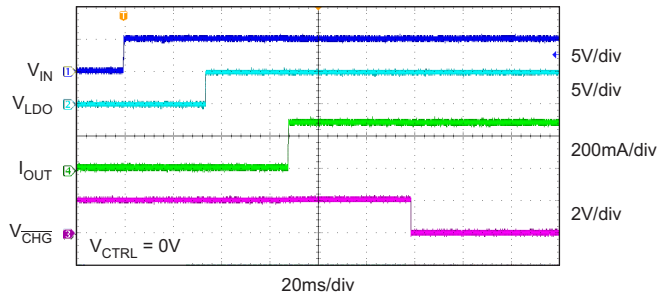


Figure 1. Adapter Plug-In With Battery Connected

G001

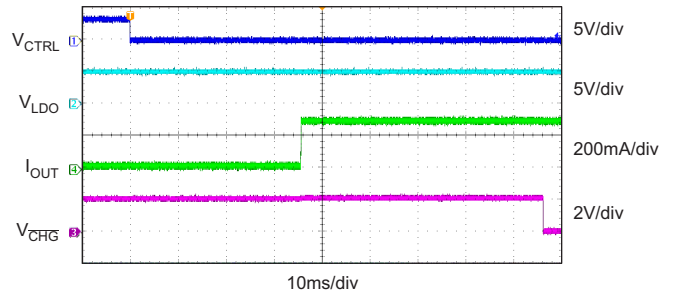


Figure 2. Charger Enable Using CTRL

G002

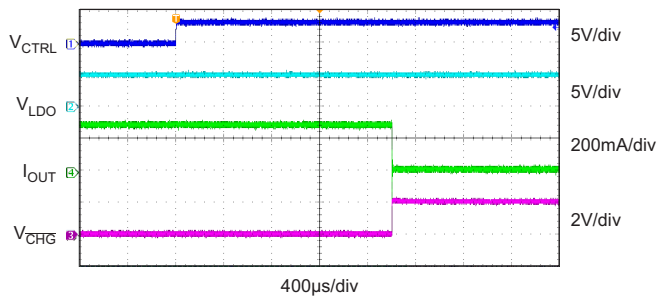


Figure 3. Charger Disable Using CTRL

G003

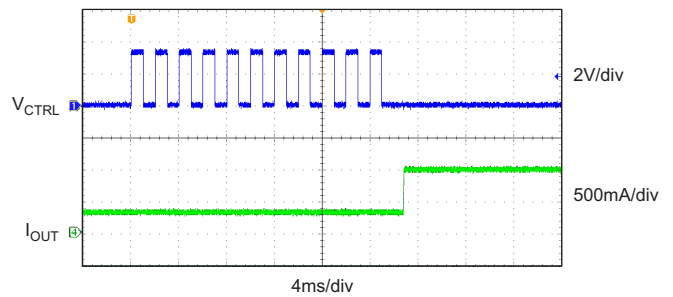


Figure 4. Default to 1A Transition Using CTRL

G004

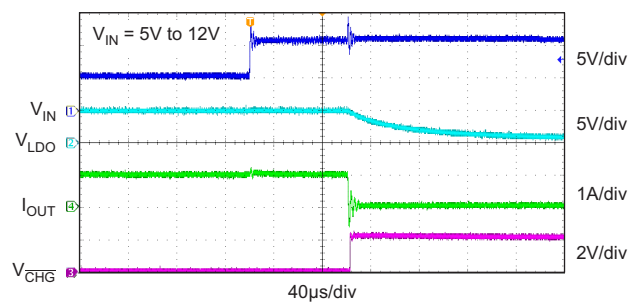


Figure 5. OVP Fault

G005

TYPICAL CHARACTERISTICS (continued)

$V_{IN} = 5\text{ V}$, $V_{BAT} = 3.2\text{ V}$, $I_{CHG} = 280\text{ mA}$, Typical Application Circuit

**VOLTAGE and CURRENT
vs
ELAPSED TIME**

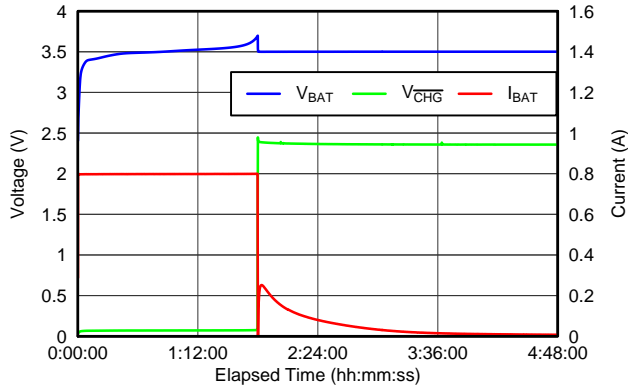


Figure 6. Complete Charge Cycle

**DROPOUT VOLTAGE
vs
TEMPERATURE**

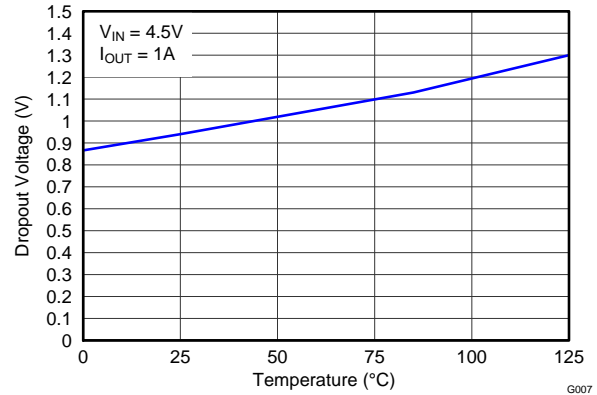


Figure 7.

**BATTERY REGULATION VOLTAGE
vs
CHARGE CURRENT**

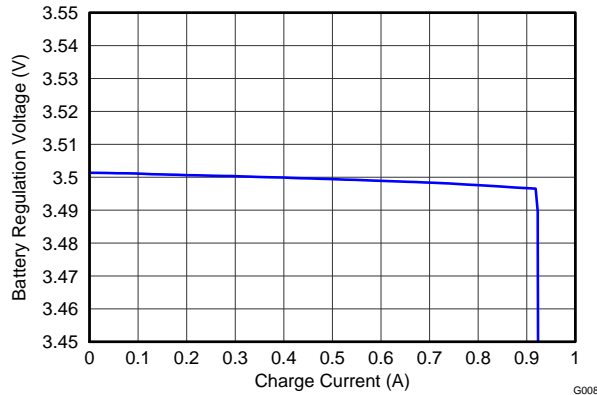


Figure 8.

**OVP THRESHOLD
vs
TEMPERATURE**

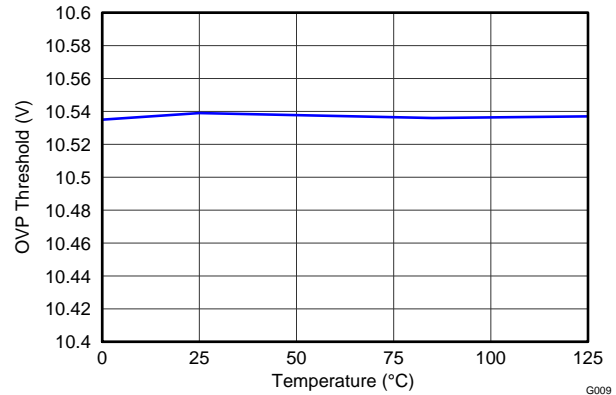


Figure 9.

**CHARGE CURRENT
vs
INPUT VOLTAGE**

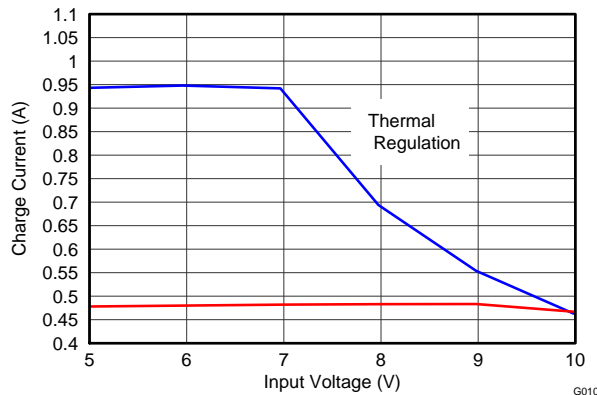


Figure 10.

**INPUT CURRENT LIMIT
vs
BATTERY VOLTAGE**

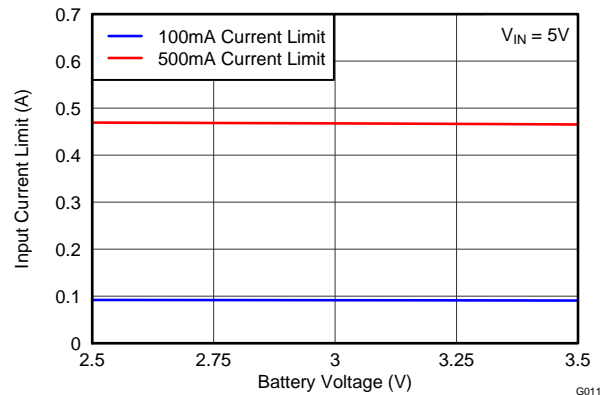
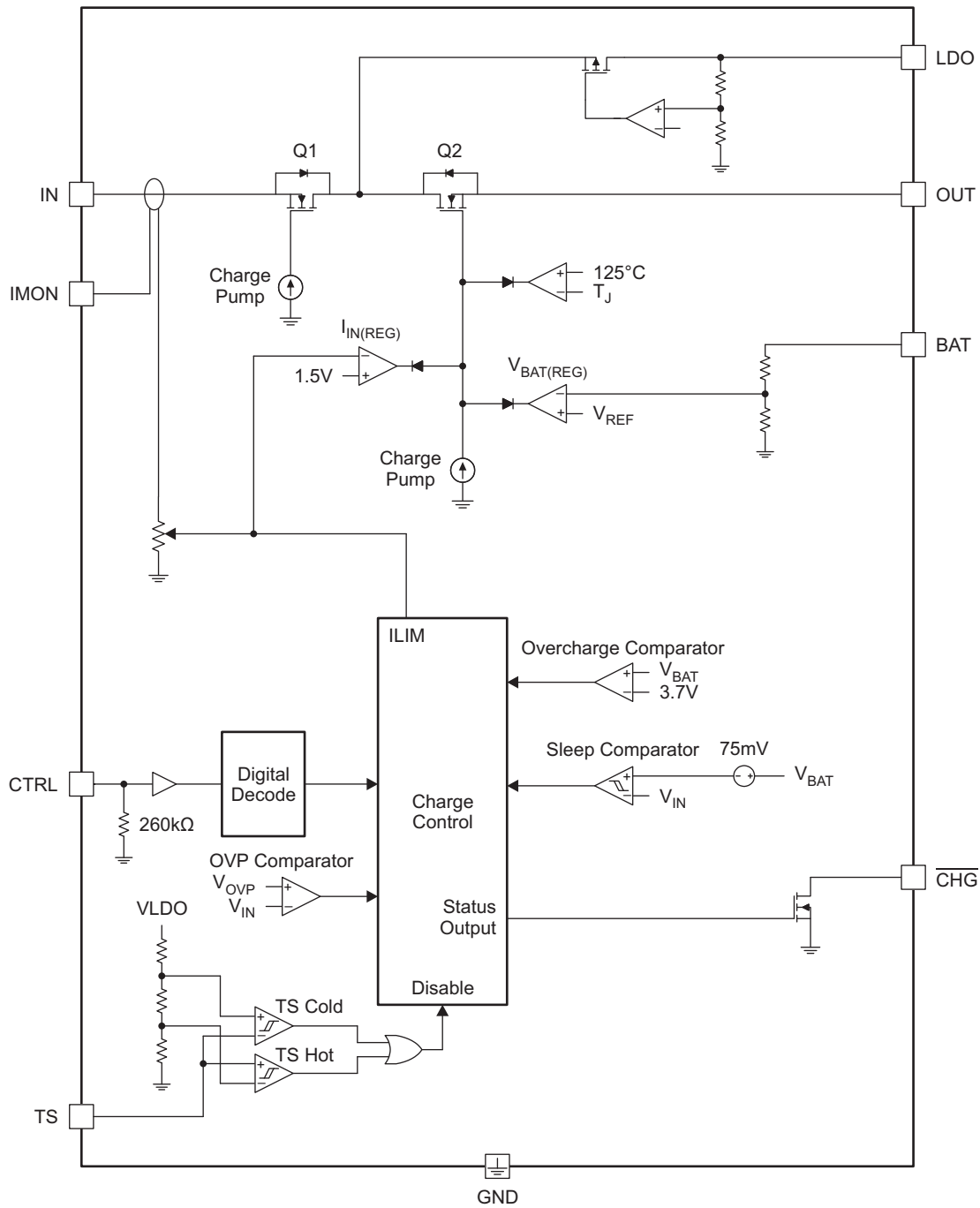
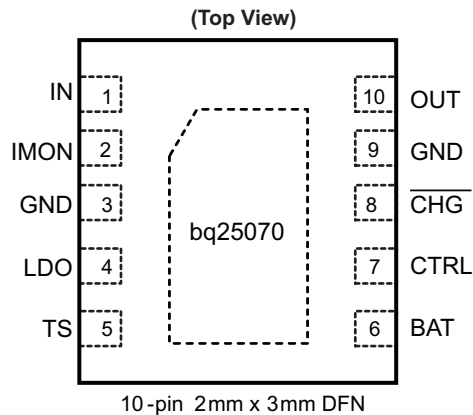


Figure 11.

SIMPLIFIED BLOCK DIAGRAM



PIN CONFIGURATION



PIN FUNCTIONS

PIN		I/O	DESCRIPTION
NAME	NO.		
IN	1	I	Input power supply. IN is connected to the external DC supply (AC adapter or USB port). Bypass IN to GND with at least a 0.1µF ceramic capacitor.
IMON	2	O	Current monitoring output. Connect a 1kΩ resistor from IMON to GND to monitor the input current. The voltage at IMON ranges from 0V to 1V which corresponds to an input current from 0A to 1A.
GND	3, 9	–	Ground terminal. Connect to the thermal pad and the ground plane of the circuit.
LDO	4	O	LDO output. LDO is regulated to 4.9V and drives up to 50mA. Bypass LDO to GND with a 0.1µF ceramic capacitor. LDO is enabled when $V_{UVLO} < V_{IN} < V_{OVP}$.
TS	5	I	Battery pack NTC monitoring input. Connect a resistor divider from LDO to GND with TS connected to the center tap to set the charge temperature window. The battery pack NTC is connected in parallel with the bottom resistor of the divider. See the Applications Design section for details on the selecting the proper component values.
BAT	6	O	Battery connection output. BAT is the sense input for the battery. Connect BAT and OUT to the battery and bypass to GND with a 1µF ceramic capacitor.
CTRL	7	I	Single-input interface Input. Drive CTRL with pulses to enable/disable the device, enable/disable V_{IN-DPM} , and select current limits. See the interface section for details on using the CTRL interface.
CHG	8	O	Charge status indicator open-drain output. CHG is pulled low while the device is charging the battery. CHG goes high impedance when the battery is fully charged.
OUT	10	O	System output connection. Connect OUT and BAT together. Bypass the OUT and BAT connection to GND with a 1µF ceramic capacitor.
Thermal PAD	Pad	–	There is an internal electrical connection between the exposed thermal pad and the GND pin of the device. The thermal pad must be connected to the same potential as the GND pin on the printed circuit board. Do not use the thermal pad as the primary ground input for the device. GND pin must be connected to ground at all times.

APPLICATIONS CIRCUITS

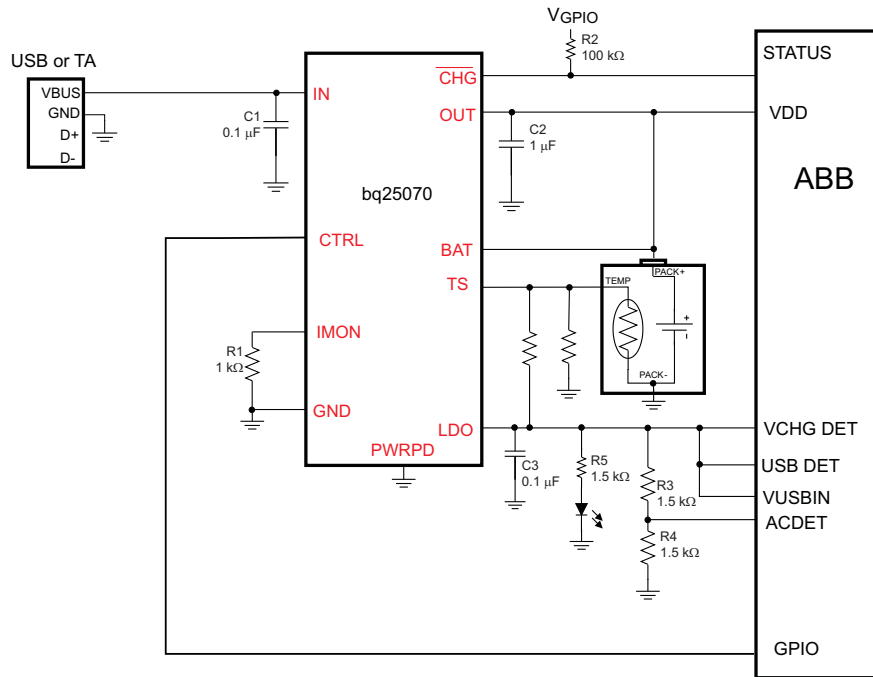


Figure 12. bq25070 Typical Application Circuit

DETAILED FUNCTIONAL DESCRIPTION

The bq25070 is a highly integrated LiFePO₄ linear battery charger targeted at space-limited portable applications. It operates from either a USB port or AC Adapter and charges a single-cell LiFePO₄ battery with up to 1A of charge current. The 30V input voltage range with input over-voltage protections supports low-cost unregulated adapters.

The LiFePO₄ charging algorithm removes the constant voltage mode control usually present in Li-Ion battery charge cycles. Instead, the battery is charged with the fastcharge current to the overcharge voltage and then allowed to relax to a lower float charge voltage threshold. The removal of the constant voltage control reduces charge time significantly. During the charge cycle, an internal control loop monitors the IC junction temperature and reduces the charge current if an internal temperature threshold is exceeded. The charger power stage and charge current sense functions are fully integrated. The charger function has high accuracy voltage and current regulation loops, and charge status display.

CHARGING OPERATION

The bq25070 uses a charge algorithm that is unique to LiFePO₄ chemistry cells. The constant voltage mode control usually present in Li-Ion battery charge cycles is eliminated. This dramatically decreases the charge time. When the bq25070 is enabled by CTRL, the battery voltage is monitored to verify which stage of charging must be used. When $V_{BAT} < V_{LOWV}$, the bq25070 charges in precharge mode; when $V_{BAT} > V_{LOWV}$, the normal charge cycle is used.

Charger Operation with Minimum System Voltage Mode Enabled

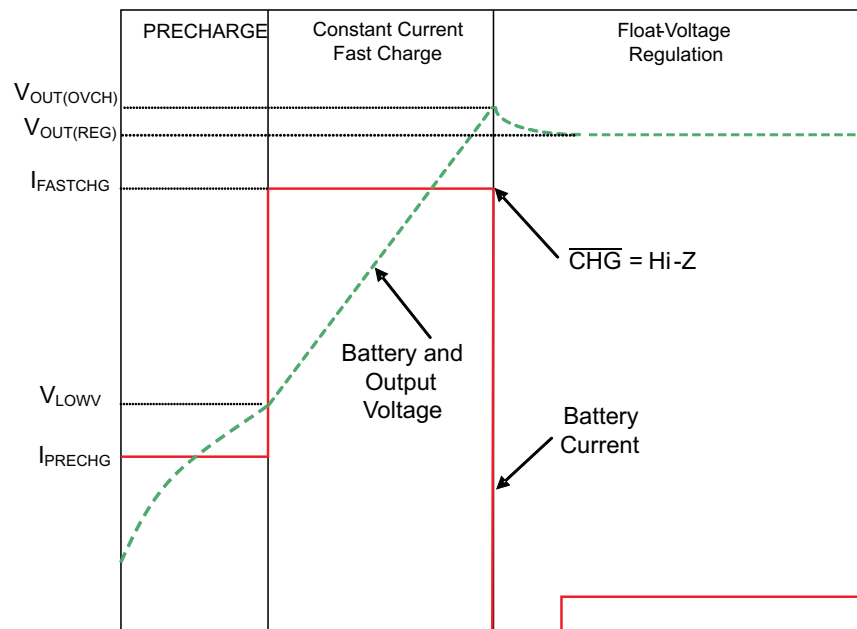


Figure 13. Typical Charging Cycle with Minimum System Voltage Enabled

Precharge Mode ($V_{BAT} \leq V_{LOWV}$)

The bq25070 enters precharge mode when $V_{BAT} \leq V_{LOWV}$. Upon entering precharge mode, the battery is charged with a 47.5mA current and \overline{CHG} goes low.

Fast Charge Mode

Once $V_{BAT} > V_{LOWV}$, the bq25070 enters constant current (CC) mode where charge current is regulated using the internal MOSFETs between IN and OUT. The total current is shared between the output load and the battery. Once the battery voltage charges up to $V_{BAT(OVCH)}$, the CHG output goes high indicating the charge cycle is complete and the bq25070 switches the battery regulation voltage to $V_{BAT(REG)}$. The battery voltage is allowed to relax down to $V_{BAT(REG)}$. The charger remains enabled and regulates the output to $V_{BAT(REG)}$. If at any time the battery falls below V_{REC} , the charge cycle restarts.

CHARGE CURRENT TRANSLATOR (IMON)

When the charger is enabled, internal circuits generate a current proportional to the charge current at the IMON input. The current out of IMON is 1/1000 ($\pm 10\%$) of the charge current. This current, when applied to the external charge current programming resistor, R1 (Figure 12), generates an analog voltage that can be monitored by an external host to calculate the current sourced from BAT. Connect a 1k Ω resistor from IMON to GND. The voltage at IMON is calculated as:

$$V_{IMON} = I_{IN} \times 1 \frac{V}{A} \quad (1)$$

INPUT OVER VOLTAGE PROTECTION

The bq25070 contains an input over voltage protection circuit that disables the LDO output and charging when the input voltage rises above V_{OVP} . This prevents damage from faulty adapters. The OVP circuitry contains an 115 μ s deglitch that prevents ringing on the input from line transients from tripping the OVP circuitry falsely. If an adapter with an output greater than V_{OVP} is plugged in, the IC completes soft-start power up and then shuts down if the voltage remains above V_{OVP} after 115 μ s. The LDO remains off and charging remains disabled until the input voltage falls below V_{OVP} .

UNDER-VOLTAGE LOCKOUT (UVLO)

The bq25070 remains in power down mode when the input voltage is below the under-voltage lockout threshold (V_{UVLO}). During this mode, the control input (CTRL) is ignored. The LDO, the charge FET connected between IN and OUT are off and the status output (CHG) is high impedance. Once the input voltage rises above V_{UVLO} , the internal circuitry is turned on and the normal operating procedures are followed.

EXTERNAL NTC MONITORING (TS)

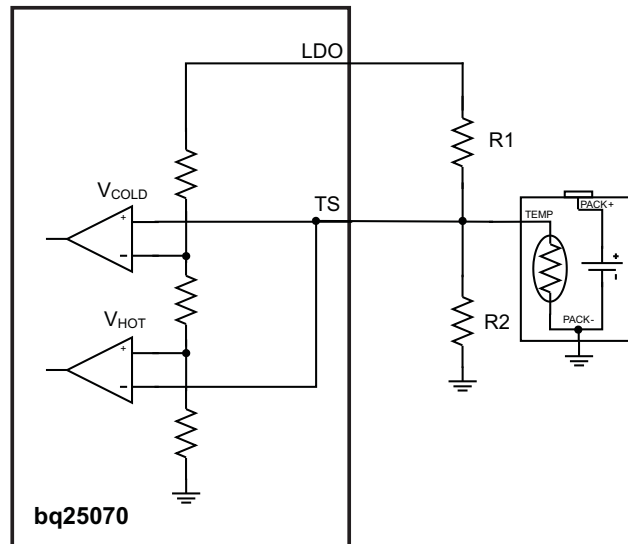
The bq25070 features a flexible, voltage based external battery pack temperature monitoring input. The TS input connects to the NTC thermistor in the battery pack to monitor battery temperature and prevent dangerous over-temperature conditions. During charging, the voltage at TS is continuously monitored. If, at any time, the voltage at TS is outside of the operating range (V_{COLD} to V_{HOT}), charging is suspended. When the voltage measured at TS returns to within the operation window, charging is resumed. When charging is suspended due to a battery pack temperature fault, the CHG output remains low and continues to indicate charging.

The temperature thresholds are programmed using a resistor divider from LDO to GND with the NTC thermistor connected to the center tap from TS to GND. See Figure 14 for the circuit example. The value of R1 and R2 are calculated using the following equations:

$$R1 = \frac{-R2 \times RHOT \times (0.125 - 1)}{0.125 \times (R2 + RHOT)} \quad (2)$$

$$R2 = \frac{-RHOT \times RCOLD \times (0.125 - 0.250)}{RHOT \times 0.250 \times (0.125 - 1) + RCOLD \times 0.125 \times (1 - 0.250)} \quad (3)$$

RHOT is the expected thermistor resistance at the programmed hot threshold; RCOLD is the expected thermistor resistance at the programmed cold threshold.



For applications that do not require the TS monitoring function, set R1 = 490k Ω and R2 = 100k Ω to set the TS voltage at a valid level and maintain charging.

Figure 14. NTC Monitoring Function

50 mA LDO (LDO)

The LDO output of the bq25070 is a low dropout linear regulator (LDO) that supplies up to 50mA while regulating to V_{LDO} . The LDO is active whenever the input voltage is above V_{UVLO} and below V_{OVP} . It is not affected by the CTRL input. The LDO output is used to power and protect circuitry such as USB transceivers from transients on the input supply.

CHARGE STATUS INDICATOR (\overline{CHG})

The bq25070 contains an open drain \overline{CHG} output that indicates when charge cycles and faults. When charging a battery in precharge or fastcharge mode, the \overline{CHG} output is pulled to GND. Once the BAT output reaches the overcharge voltage threshold, \overline{CHG} goes high impedance to signal the battery is fully charged. The \overline{CHG} output goes low during battery recharge cycles to signal the host.

Additionally, \overline{CHG} notifies the host if a NTC temperature fault has occurred. \overline{CHG} pulses with a period of 100ms and a 50% duty cycle if a TS faults occurs. Connect \overline{CHG} to the required logic level voltage through a 1k Ω to 100k Ω resistor to use the signal with a microprocessor. I_{CHG} must be below 5mA.

The IC monitors the CHG pin when no input is connected to verify if the system circuitry is active. If the voltage at CHG is logic being drive low when no input is connected, the TS circuit is turned off for a low quiescent current state. Once the voltage at CHG increases above logic high, the TS circuit is turned on.

SINGLE INPUT INTERFACE (CTRL)

CTRL is used to enable/disable the device as well as select the input current limit, enable/disable charge, extend the TS operation range and disable V_{IN} -DPM mode. CTRL is pulled low to enable the device. After the 50 μ s deglitch expires, the IC enters the 32ms WAIT state. CTRL may be used to program the bq25070 during this time. Once t_{WAIT} expires, the IC starts up. If no command is sent to CTRL during t_{WAIT} , the IC starts up with a default 285mA current limit.

Programming the different modes is done by pulsing the CTRL input. See [Table 1](#) for a map of the different modes. The width of the CTRL pulses is unimportant as long as they are between 50 μ s and 1000 μ s long. The time between pulses must be between 50 μ s and 1000 μ s to be properly read. Once CTRL is held low for 2ms, the number of pulses is passed to the control logic and decoded and then the mode changes. To ensure proper operation, do not send more than 16 pulses in one programming cycle.

Table 1. Pulse Counting Map for CTRL Interface

# of Pulses	Current Limit
1	No Change
2	No Change
3	No Change
4	93 mA
5	187 mA
6	280 mA
7	374 mA
8	467 mA
9	654 mA
10	794 mA
11	935 mA
>11	No Change

If, at any time, the CTRL input is held high for more than 2ms, the IC is disabled. When disabled, charging is suspended and the bq25070 input quiescent current is reduced.

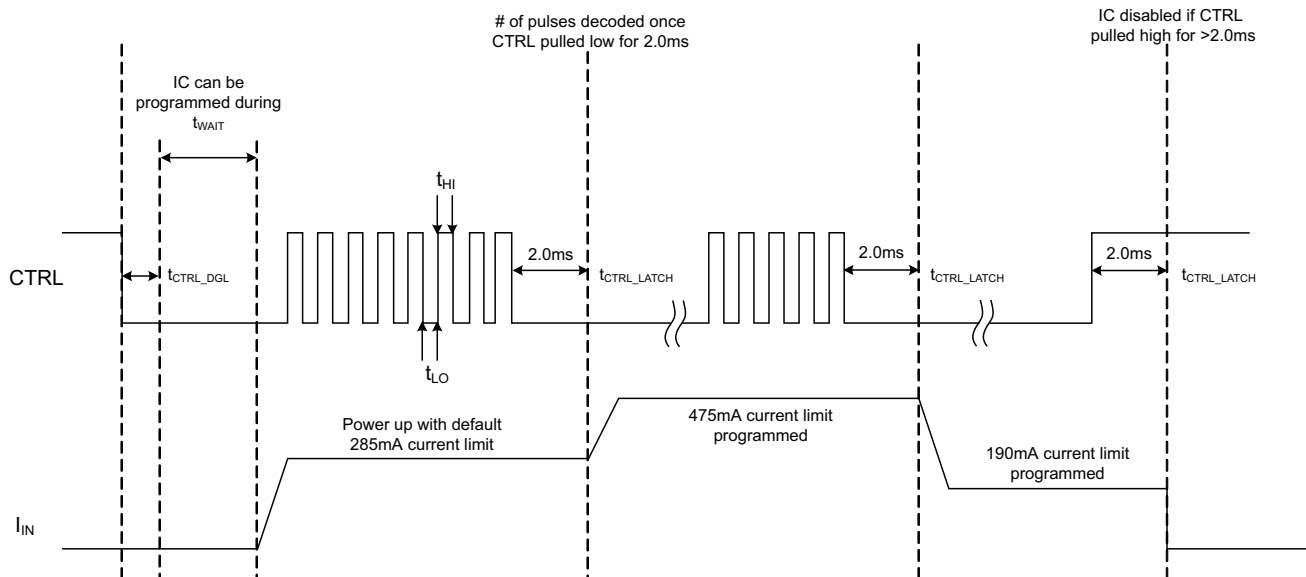


Figure 15. CTRL Timing Diagram

THERMAL REGULATION AND THERMAL SHUTDOWN

The bq25070 contains a thermal regulation loop that monitors the die temperature continuously. If the temperature exceeds $T_{J(REG)}$, the device automatically reduces the charging current to prevent the die temperature from increasing further. In some cases, the die temperature continues to rise despite the operation of the thermal loop, particularly under high V_{IN} conditions. If the die temperature increases to $T_{J(OFF)}$, the IC is turned off. Once the device die temperature cools by $T_{J(OFF-HYS)}$, the device turns on and returns to thermal regulation. Continuous over-temperature conditions result in the pulsing of the load current. If the junction temperature of the device exceeds $T_{J(OFF)}$, the charge FET is turned off. The FET is turned back on when the junction temperature falls below $T_{J(OFF)} - T_{J(OFF-HYS)}$.

Note that these features monitor the die temperature of the bq25070. This is not synonymous with ambient temperature. Self heating exists due to the power dissipated in the IC because of the linear nature of the battery charging algorithm.

APPLICATION INFORMATION

SELECTION OF INPUT/OUTPUT CAPACITORS

In most applications, all that is needed is a high-frequency decoupling capacitor on the input power pin. For normal charging applications, a 0.1µF ceramic capacitor, placed in close proximity to the IN pin and GND pad works best. In some applications, depending on the power supply characteristics and cable length, it may be necessary to increase the input filter capacitor to avoid exceeding the OVP voltage threshold during adapter hot plug events where the ringing exceeds the deglitch time.

The charger in the bq25070 requires a capacitor from OUT to GND for loop stability. Connect a 1µF ceramic capacitor from BAT to GND close to the pins for best results. More output capacitance may be required to minimize the output droop during large load transients.

The LDO also requires an output capacitor for loop stability. Connect a 0.1µF ceramic capacitor from LDO to GND close to the pins. For improved transient response, this capacitor may be increased.

THERMAL CONSIDERATIONS

The bq25070 is packaged in a thermally enhanced QFN package. The package includes a thermal pad to provide an effective thermal contact between the IC and the printed circuit board (PCB). Full PCB design guidelines for this package are provided in the application note entitled: *QFN/SON PCB Attachment Application Note (SLUA271)*.

The most common measure of package thermal performance is thermal impedance (θ_{JA}) measured (or modeled) from the chip junction to the air surrounding the package surface (ambient). The mathematical expression for θ_{JA} is:

Where:

$$\theta_{JA} = \frac{T_J - T_A}{P_D} \quad (4)$$

T_J = chip junction temperature

T_A = ambient temperature

P_D = device power dissipation

Factors that can greatly influence the measurement and calculation of θ_{JA} include:

- Whether or not the device is board mounted
- Trace size, composition, thickness, and geometry
- Orientation of the device (horizontal or vertical)
- Volume of the ambient air surrounding the device under test and airflow
- Whether other surfaces are in close proximity to the device being tested

The device power dissipation, P_D , is a function of the charge rate and the voltage drop across the internal PowerFET. It can be calculated from the following equation when a battery pack is being charged:

$$P_D = (V_{IN} - V_{OUT}) \times I_{OUT}$$

Due to the charge profile of LiFePO₄ batteries the maximum power dissipation is typically seen at the beginning of the charge cycle when the battery voltage is at its lowest. See the charging profile, [Figure 13](#). If the board thermal design is not adequate the programmed fast charge rate current may not be achieved under maximum input voltage and minimum battery voltage, as the thermal loop can be active, effectively reducing the charge current to avoid excessive IC junction temperature.

PCB LAYOUT CONSIDERATIONS

It is important to pay special attention to the PCB layout. The following provides some guidelines:

- To obtain optimal performance, the decoupling capacitor from IN to GND (thermal pad) and the output filter capacitors from OUT to GND (thermal pad) should be placed as close as possible to the bq25070, with short trace runs to both IN, OUT and GND (thermal pad).

- All low-current GND connections should be kept separate from the high-current charge or discharge paths from the battery. Use a single-point ground technique incorporating both the small signal ground path and the power ground path.
- The high current charge paths into IN pin and from the OUT pin must be sized appropriately for the maximum charge current in order to avoid voltage drops in these traces.
- The bq25070 is packaged in a thermally enhanced SON package. The package includes a thermal pad to provide an effective thermal contact between the IC and the printed circuit board (PCB); this thermal pad is also the main ground connection for the device. Connect the thermal pad to the PCB ground connection. Full PCB design guidelines for this package are provided in the application note entitled: *QFN/SON PCB Attachment Application Note* ([SLUA271](#)).

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp (3)	Op Temp (°C)	Top-Side Markings (4)	Samples
BQ25070DQCR	ACTIVE	WSO	DQC	10	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	QUS	Samples
BQ25070DQCT	ACTIVE	WSO	DQC	10	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	QUS	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBsolete: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) Multiple Top-Side Markings will be inside parentheses. Only one Top-Side Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Top-Side Marking for that device.

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TAPE AND REEL INFORMATION



QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
BQ25070DQCR	WSO	DQC	10	3000	180.0	8.4	2.25	3.25	1.05	4.0	8.0	Q1
BQ25070DQCR	WSO	DQC	10	3000	180.0	8.4	2.25	3.25	1.05	4.0	8.0	Q1
BQ25070DQCT	WSO	DQC	10	250	180.0	12.4	2.25	3.25	1.05	4.0	8.0	Q1
BQ25070DQCT	WSO	DQC	10	250	180.0	8.4	2.25	3.25	1.05	4.0	8.0	Q1

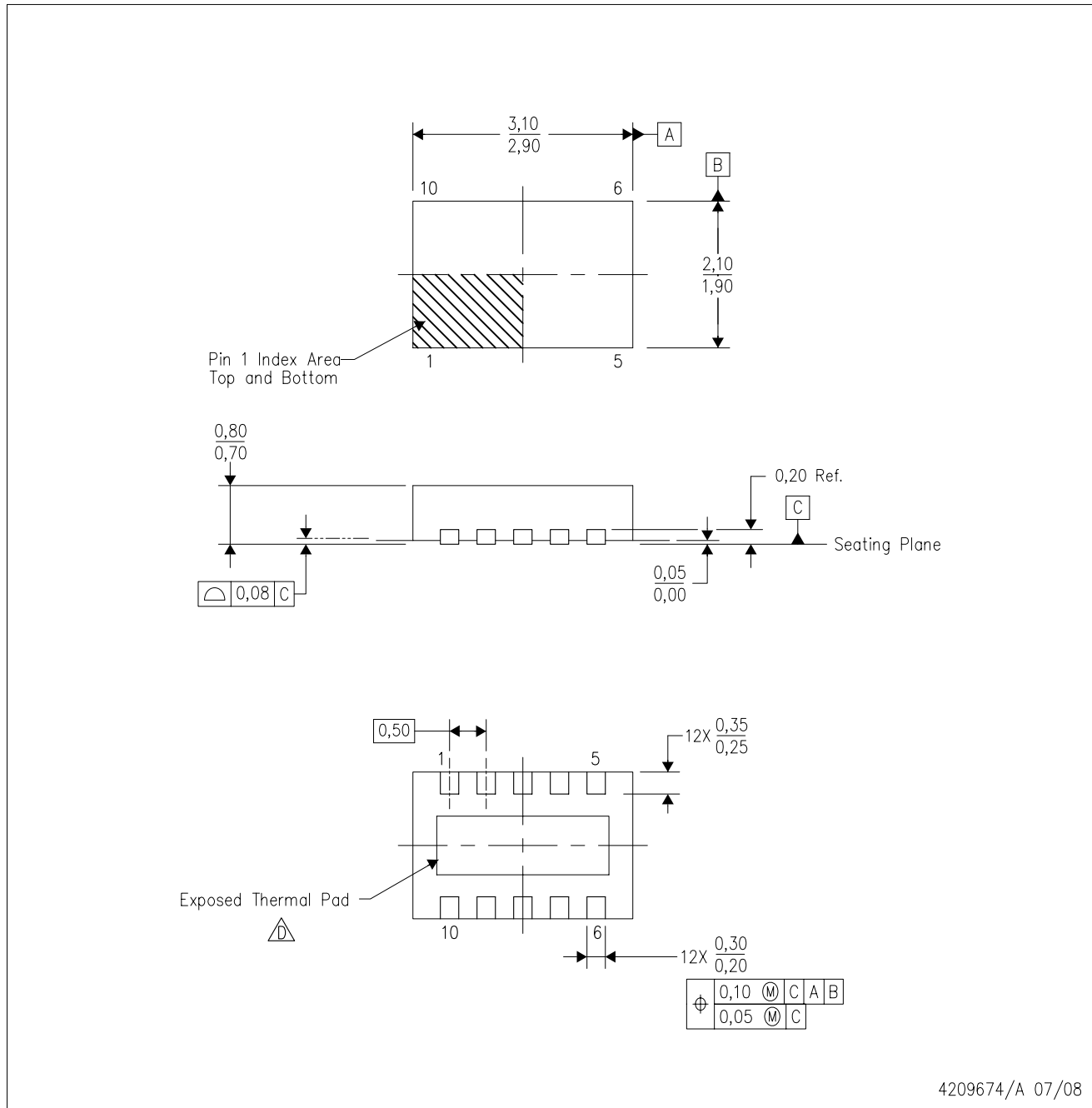
TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
BQ25070DQCR	WSON	DQC	10	3000	210.0	185.0	35.0
BQ25070DQCR	WSON	DQC	10	3000	210.0	185.0	35.0
BQ25070DQCT	WSON	DQC	10	250	210.0	185.0	35.0
BQ25070DQCT	WSON	DQC	10	250	210.0	185.0	35.0

DQC (R-PWSON-N10)

PLASTIC SMALL OUTLINE NO-LEAD



- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - B. This drawing is subject to change without notice.
 - C. SON (Small Outline No-Lead) package configuration.
 -  The package thermal pad must be soldered to the board for thermal and mechanical performance. See the Product Data Sheet for details regarding the exposed thermal pad dimensions.

THERMAL PAD MECHANICAL DATA

DQC (R-PWSON-N10)

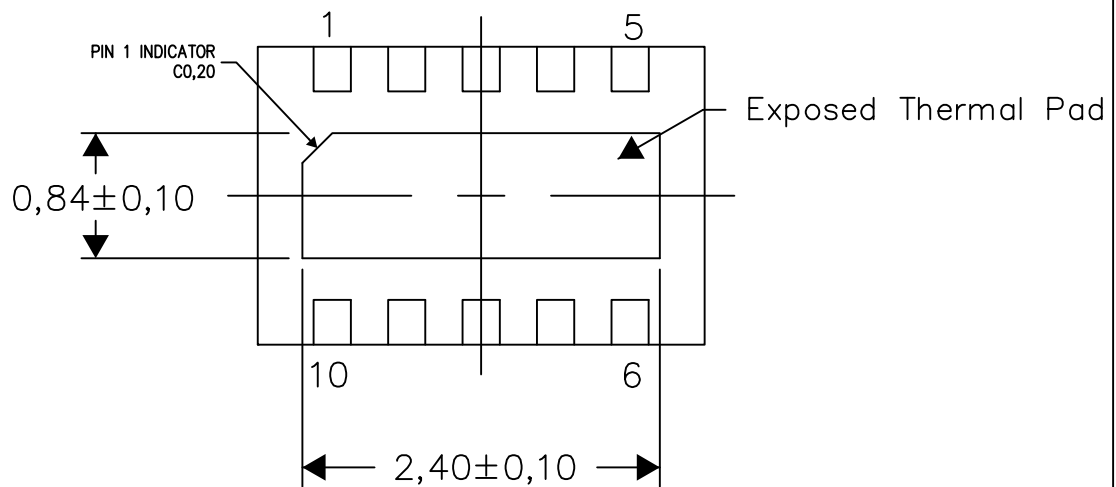
PLASTIC SMALL OUTLINE NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

Exposed Thermal Pad Dimensions

4209909/D 01/14

NOTE: All linear dimensions are in millimeters

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